

# FH1404G6

N-Channel Enhancement Mode Power MOSFET

## Description

The FH1404G6 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

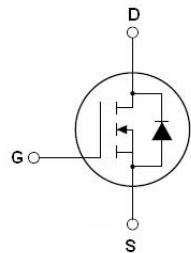
## Application

- Motor drivers
- DC/DC Converters In Computing

## General Features

$R_{DS(ON)} \leq 8.5\text{m}\Omega @ V_{GS} = 10\text{ V}$   
 $R_{DS(ON)} \leq 12\text{ m}\Omega @ V_{GS} = 4.5\text{ V}$

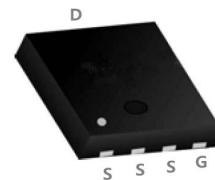
- Surface -mounted package
- Super Trench
- Low Thermal Resistance
- Low ciss



Schematic diagram



Marking and pin Assignment



PDFN3.3x3.3-8L top and bottom view

## Limiting Values

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	Drain-Source Voltage	$T_C = 25\text{ }^\circ\text{C}$	40	-	V
$V_{GS}$	Gate-Source Voltage	$T_C = 25\text{ }^\circ\text{C}$	-	$\pm 20$	V
$I_D^*$	Drain Current	$T_C = 25\text{ }^\circ\text{C}, V_{GS} = 10\text{ V}$	-	40	A
$I_{D^*}^{***}$	Pulsed Source Current	$T_C = 25\text{ }^\circ\text{C}, V_{GS} = 10\text{ V}$	-	120	A
$P_{tot}^*$	Total Power Dissipation	$T_C = 25\text{ }^\circ\text{C}$	-	20.8	W
$T_{stg}$	Storage Temperature		-55	150	$^\circ\text{C}$
$T_J$	Junction Temperature		-	150	$^\circ\text{C}$
$I_S$	Diode Forward Current	$T_C = 25\text{ }^\circ\text{C}$	-	40	A
$E_{AS}^*$	Single Pulsed Avalanche Energy	$V_{DD} = 40\text{ V}, L = 0.5\text{ mH}$	-	48	mJ
$R_{\theta JA}^*$	Thermal Resistance- Junction to Ambient		-	61.8	$^\circ\text{C} / \text{W}$
$R_{\theta JC}^*$	Thermal Resistance- Junction to Case		-	6	$^\circ\text{C} / \text{W}$

Notes :

\* Surface Mounted on 1 in<sup>2</sup> pad area, t ≤ 10 sec

\*\* Pulse width ≤ 300 μs, duty cycle ≤ 2 %

\*\*\* limited by bonding wire

**Electrical Characteristics** (  $T_A=25^\circ$  Unless Otherwise Noted )

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	40	-	-	V
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_{DS} = 250 \mu\text{A}$	1	-	2	V
$I_{DSS}$	Zero Gate Voltage Source Current	$V_{DS} = 36 \text{ V}$ , $V_{GS} = 0 \text{ V}$ $T_J = 85^\circ\text{C}$	-	-	1	$\mu\text{A}$
$I_{GSS}$	Gate Leakage Current	$V_{GS} = \pm 20 \text{ V}$ , $V_{DS} = 0 \text{ V}$	-	-	$\pm 100$	nA
$R_{DS(\text{ON})}^a$	Drain-Source On-State Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 15 \text{ A}$	-	6.0	8.5	mΩ
		$V_{GS} = 4.5 \text{ V}$ , $I_D = 10 \text{ A}$	-	8.0	12	
<b>Diode Characteristics</b>						
$V_{SD}^a$	Diode Forward Voltage	$I_{SD} = 20 \text{ A}$ , $V_{GS} = 0 \text{ V}$	-	-	1.3	V
$t_{rr}$	Reverse Recovery Time	$I_{SD} = 20 \text{ A}$ , $dI_{SD}/dt = 100 \text{ A}/\mu\text{s}$	-	26	-	nS
$Q_{rr}$	Reverse Recovery Charge		-	8.8	-	nC
<b>Dynamic Characteristics</b> <sup>b</sup>						
$C_{iss}$	Input Capacitance	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 22.5 \text{ V}$ Frequency = 1 MHz	-	720	-	pF
$C_{oss}$	Output Capacitance		-	184	-	
$C_{rss}$	Reverse Transfer Capacitance		-	34	-	
$t_d(\text{on})$	Turn-on Delay Time	$V_{DS} = 22.5 \text{ V}$ , $V_{GEN} = 10 \text{ V}$ , $R_G = 4.5 \Omega$ , $R_L = 1.12 \Omega$ , $I_D = 20 \text{ A}$	-	5.1	-	nS
$t_r$	Turn-on Rise Time		-	41	-	
$t_d(\text{off})$	Turn-off Delay Time		-	14	-	
$t_f$	Turn-off Fall Time		-	7.4	-	
<b>Gate Charge Characteristics</b> <sup>b</sup>						
$Q_g$	Total Gate Charge	$V_{GS} = 10 \text{ V}$ , $V_{DS} = 22.5 \text{ V}$ , $I_{DS} = 20 \text{ A}$	-	14	-	nC
$Q_{gs}$	Gate-Source Charge		-	3.1	-	
$Q_{gd}$	Gate-Drain Charge		-	2.9	-	

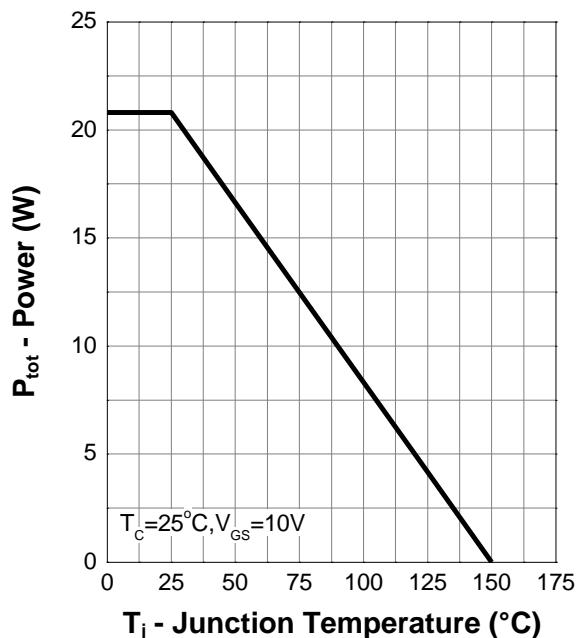
Notes :

a : Pulse test ; pulse width  $\leq 300 \mu\text{s}$ , duty cycle  $\leq 2 \%$ 

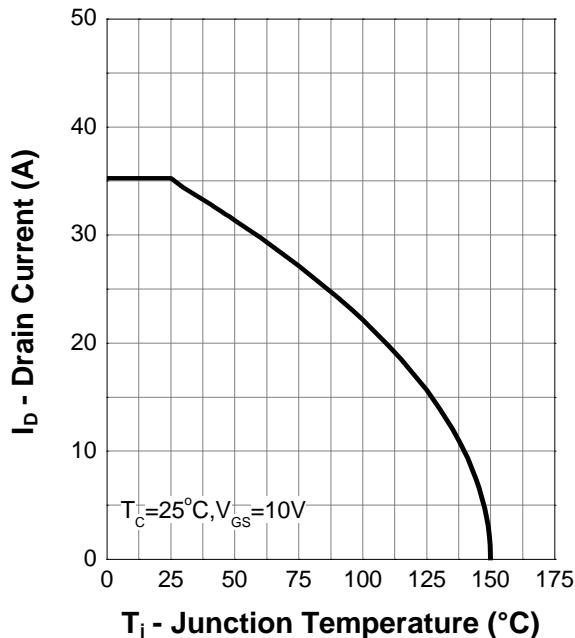
b : Guaranteed by design, not subject to production testing

## Typical Characteristics (cont.)

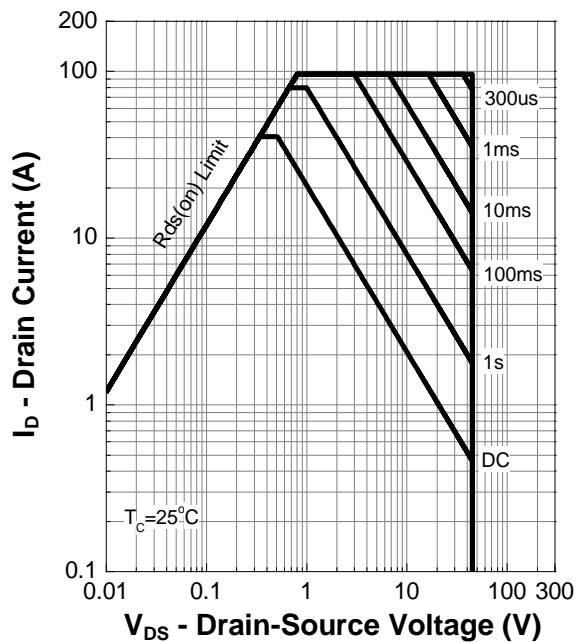
**Power Capability**



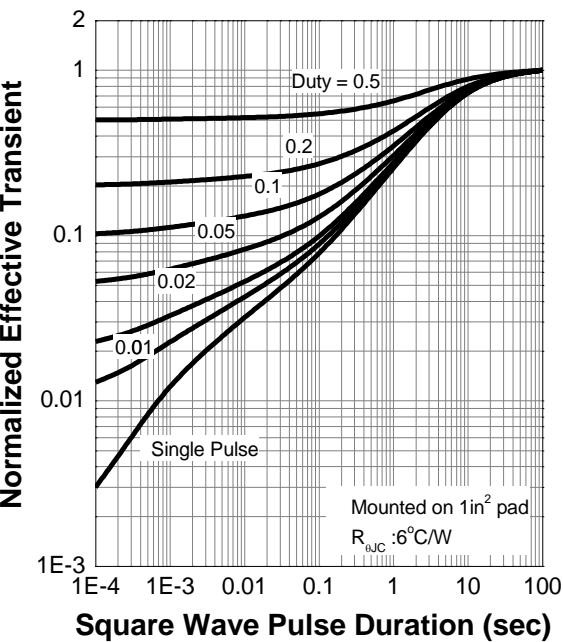
**Current Capability**



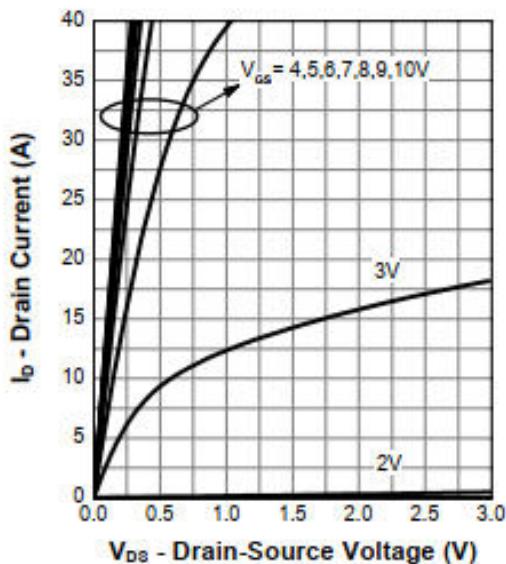
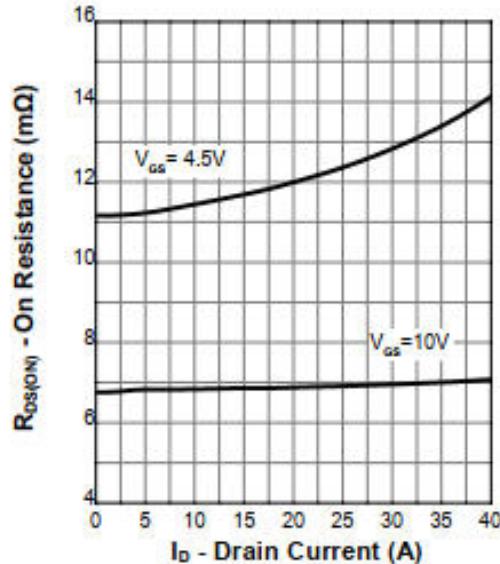
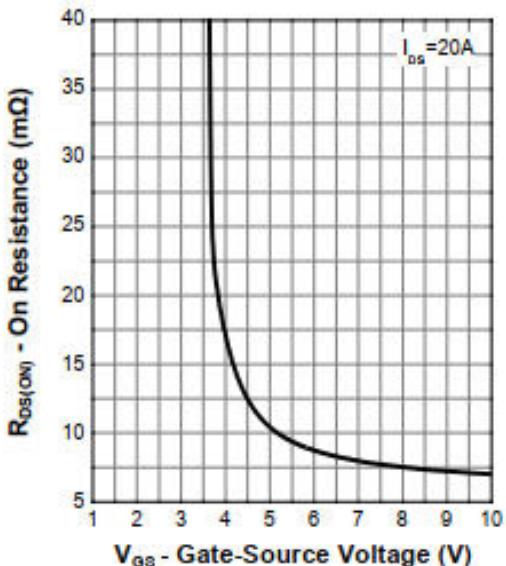
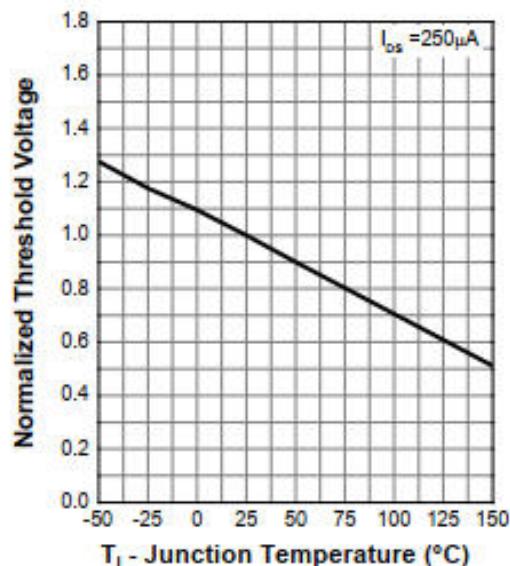
**Safe Operating Area**



**Transient Thermal Impedance**

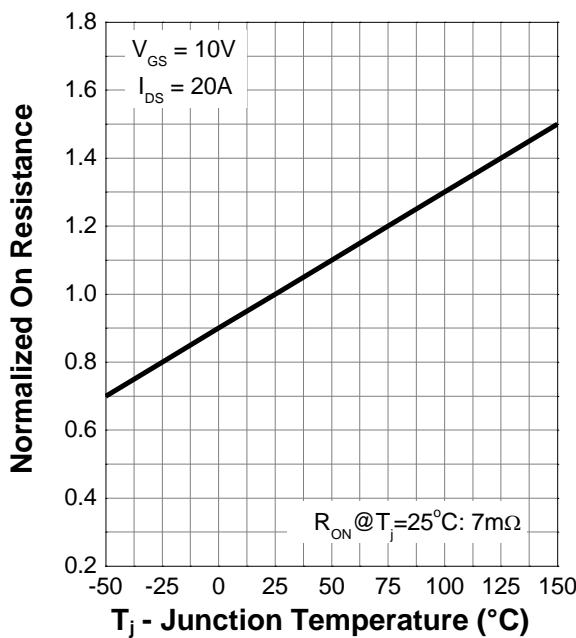


## Typical Characteristics (cont.)

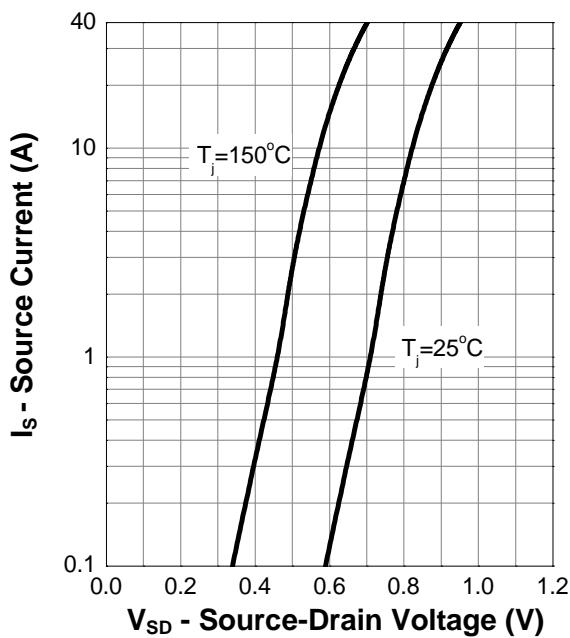
**Output Characteristics****On Resistance****Transfer Characteristics****Normalized Threshold Voltage**

## Typical Characteristics (cont.)

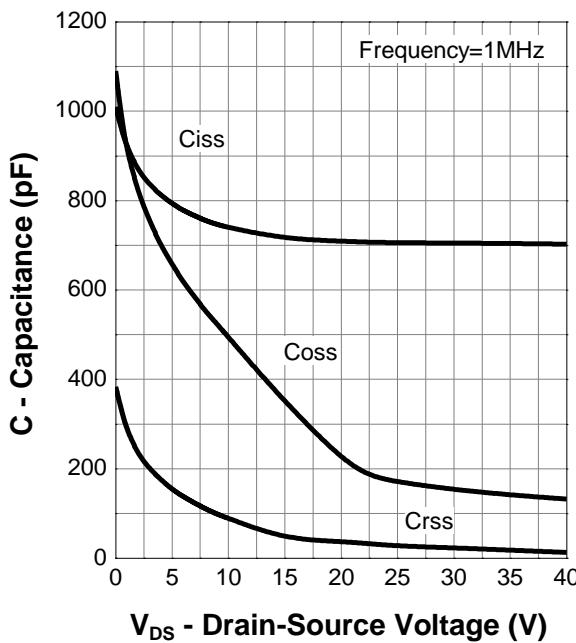
**Normalized On Resistance**



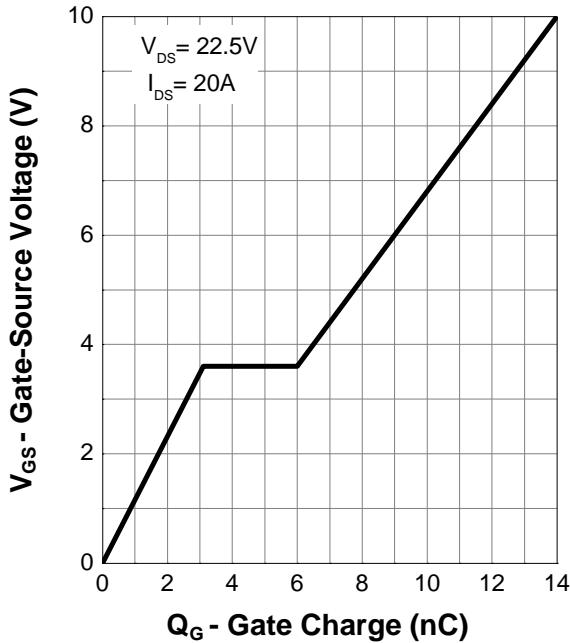
**Diode Forward Current**

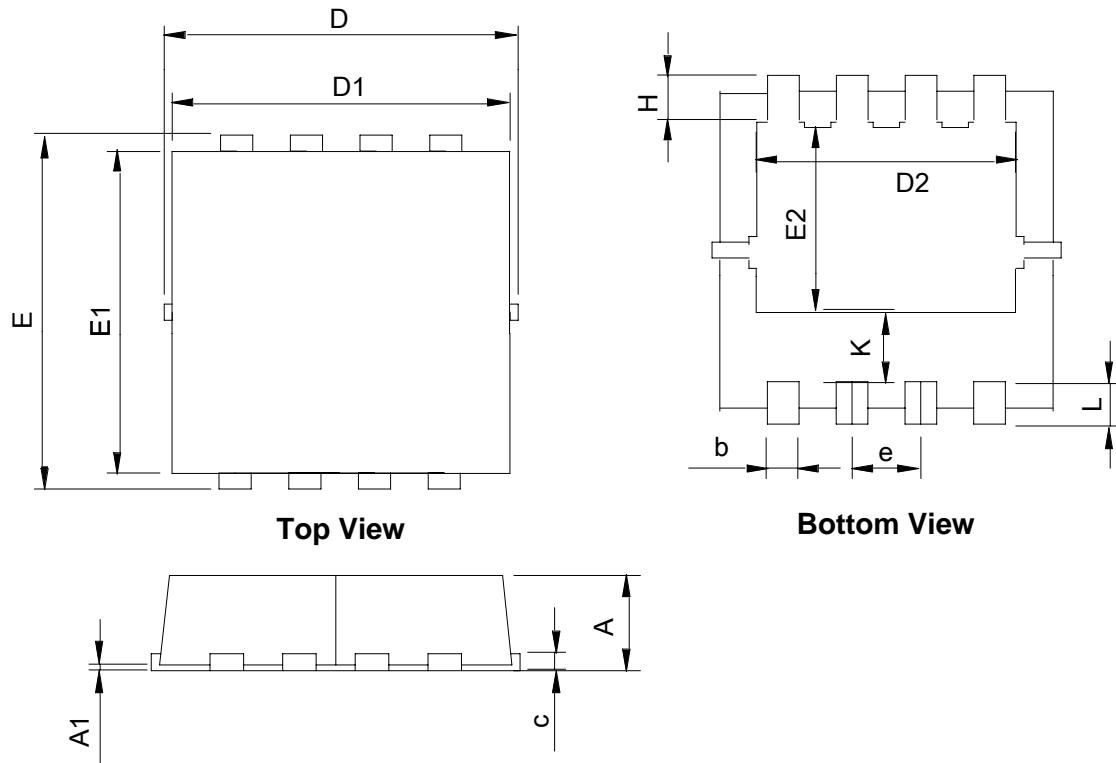


**Capacitance**



**Gate Charge**



**Package Information : PDFN3.3x3.3-8L**

SYMBOL	PDFN3.3x3.3-8L			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.70	1.00	0.028	0.039
A1	0.00	0.05	0.000	0.002
b	0.25	0.35	0.010	0.014
c	0.14	0.20	0.006	0.008
D	3.10	3.50	0.122	0.138
D1	3.05	3.25	0.120	0.128
D2	2.35	2.55	0.093	0.100
E	3.10	3.50	0.122	0.138
E1	2.90	3.10	0.114	0.122
E2	1.64	1.84	0.065	0.072
e	0.65 BSC		0.026 BSC	
H	0.32	0.52	0.013	0.020
K	0.59	0.79	0.023	0.031
L	0.25	0.55	0.010	0.022